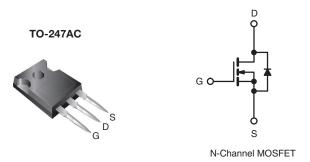


Vishay Siliconix

## **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	400				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.20				
Q <sub>g</sub> (Max.) (nC)	110				
Q <sub>gs</sub> (nC)	28				
Q <sub>gd</sub> (nC)	45				
Configuration	Single				



#### **FEATURES**

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Isolated Central Mounting Hole
- Dynamic dV/dt Rated
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

This new series of low charge Power MOSFETs achieve significantly lower gate charge over convertional MOSFETs. Utilizing advanced MOSFETs technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of MOSFETs offer the designer a new standard in power transistors for switching applications. The TO-247AC package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because of its isolated mounting hole.

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP360LCPbF		
Lead (FD)-lifee	SiHFP360LC-E3		
SnPb	IRFP360LC		
SHED	SiHFP360LC		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	400	V	
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Drain Current	Voc at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$	I_	23	А	
Continuous Brain Guirent	VGS at 10 V	$T_C = 100 ^{\circ}C$	ID	14		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	91		
Linear Derating Factor				2.2	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	1200	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	23	Α	
Repetitive Avalanche Energya			E <sub>AR</sub>	28	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}\text{C}$			$P_{D}$	280	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stq</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>	7	
Mounting Torque	6 22 or N	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 of M3 Screw			1.1	N⋅m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 4.0 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 23 A (see fig. 12).
- c.  $I_{SD} \le 23$  A,  $dI/dt \le 170$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP360LC, SiHFP360LC

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.45		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I <sub>D</sub> = 1 mA	-	0.49	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>S</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		00 V, V <sub>GS</sub> = 0 V V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	25 250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 14 A <sup>b</sup>	-	-	0.20	Ω
Forward Transconductance	9 <sub>fs</sub>	+	0 V, I <sub>D</sub> = 14 A <sup>b</sup>	13	-	-	S
Dynamic				L			
Input Capacitance	C <sub>iss</sub>		- 0 V	-	3400	-	
Output Capacitance	C <sub>oss</sub>	V	$_{OS} = 0 \text{ V},$ $_{OS} = 25 \text{ V},$	-	540	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 l	f = 1.0 MHz, see fig. 5		42	-	1
Total Gate Charge	Qg			-	-	110	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 23 \text{ A}, V_{DS} = 320 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	28	
Gate-Drain Charge	Q <sub>gd</sub>		See fig. 6 and 16	-	-	45	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 200 \text{ V, } I_D = 23 \text{ A ,}$ $R_g = 4.3 \ \Omega, \ R_D = 7.9 \ \Omega, \ \text{see fig. } 10^b$		-	16	-	ns
Rise Time	t <sub>r</sub>			-	75	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	42	-	
Fall Time	t <sub>f</sub>			-	50	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s	•					L
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	23	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	92	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>s</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 23 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 %C 1	00 A -11/-1± 100 A / -h	-	400	600	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>J</sub> = 25 °C, I <sub>F</sub> =	23 A, dl/dt = 100 A/µs <sup>b</sup>	-	5.7	8.6	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-		-on is do	minated b	by L <sub>S</sub> and	L <sub>D</sub> )

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

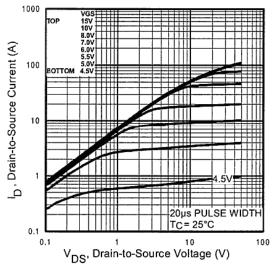


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

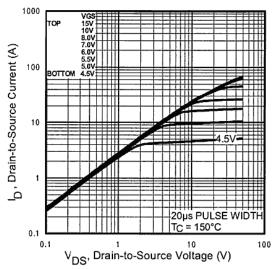


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

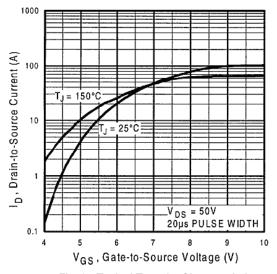


Fig. 3 - Typical Transfer Characteristics

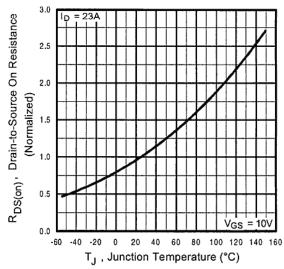


Fig. 4 - Normalized On-Resistance vs. Temperature

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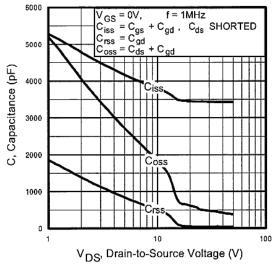


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

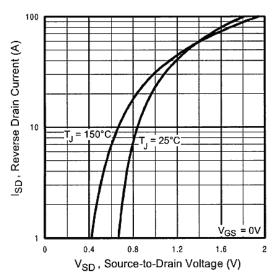


Fig. 7 - Typical Source-Drain Diode Forward Voltage

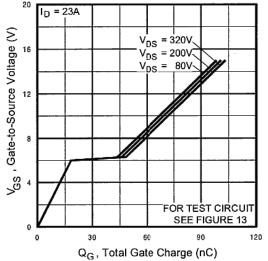


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

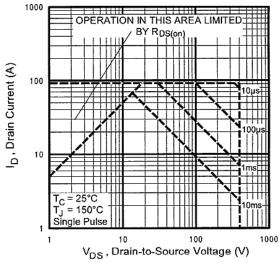


Fig. 8 - Maximum Safe Operating Area



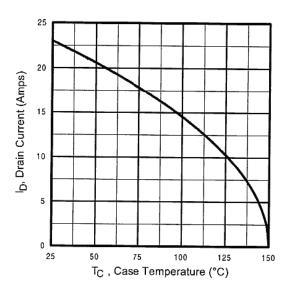


Fig. 9 - Maximum Drain Current vs. Case Temperature

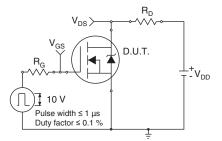


Fig. 10a - Switching Time Test Circuit

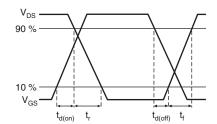


Fig. 10b - Switching Time Waveforms

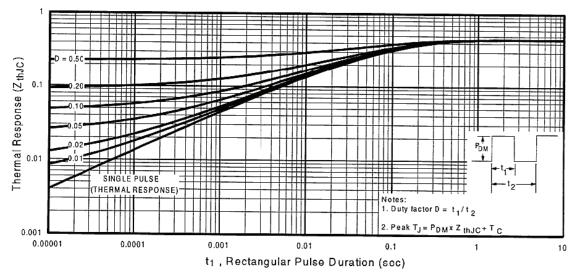
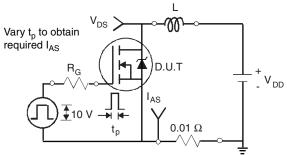


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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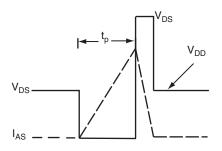


Fig. 12b - Unclamped Inductive Waveforms

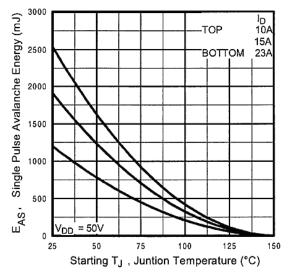


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

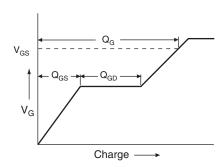


Fig. 13a - Basic Gate Charge Waveform

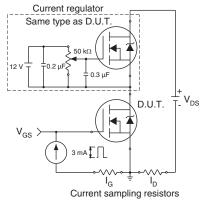
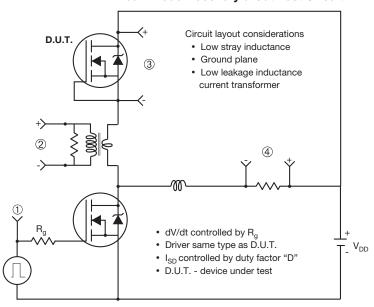


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



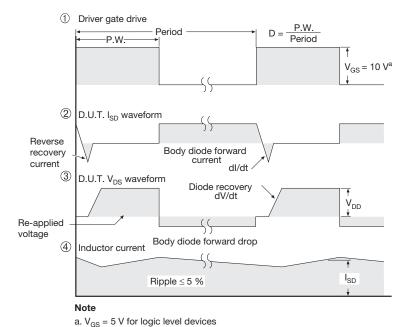
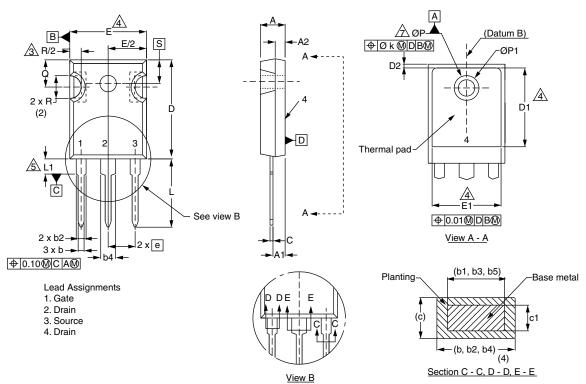


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91227.



# **TO-247AC (High Voltage)**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	-

	MILLIM	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
E	15.29	15.87	0.602	0.625	
E1	13.72	ı	0.540	ı	
е	5.46	BSC	0.215 BSC		
Øk	0.2	0.254		0.010	
L	14.20	16.25	0.559	0.640	
L1	3.71	4.29	0.146	0.169	
N	7.62 BSC		0.300 BSC		
ØΡ	3.51	3.66	0.138	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217 BSC		
0.217 800					

ECN: X13-0103-Rev. D, 01-Jul-13

DWG: 5971

### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.





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Revision: 13-Jun-16 1 Document Number: 91000